

# NSR10F30QNXT5G

## Schottky Diode Optimized for High Frequency Switching Power Supplies

These Schottky barrier diodes are optimized for low forward voltage drop and low leakage current and are offered in a Chip Scale Package (CSP) to reduce board space. The low thermal resistance enables designers to meet the challenging task of achieving higher efficiency and meeting reduced space requirements.

### Features

- Low Forward Voltage Drop – 420 mV @ 1.0 A
- Low Reverse Current – 20  $\mu$ A @ 10 V VR
- 1.0 A of Continuous Forward Current
- ESD Rating – Human Body Model: Class 3B
  - Machine Model: Class C
- High Switching Speed
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

### Typical Applications

- LCD and Keypad Backlighting
- Camera Photo Flash
- Buck and Boost dc-dc Converters
- Reverse Voltage and Current Protection
- Clamping & Protection

### Markets

- Mobile Handsets
- MP3 Players
- Digital Camera and Camcorders
- Notebook PCs & PDAs
- GPS

### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Reverse Voltage	$V_R$	30	V
Forward Current (DC)	$I_F$	1.0	A
Forward Surge Current (60 Hz @ 1 cycle)	$I_{FSM}$	18	A
ESD Rating: Human Body Model Machine Model	ESD	> 8 > 400	kV V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



ON Semiconductor®

<http://onsemi.com>

### 30 V SCHOTTKY BARRIER DIODE



**MARKING DIAGRAM**  
PIN 1  
DSN2 (0502) 10F30  
CASE 152AD YYY

10F30 = Specific Device Code  
YYY = Year Code

### ORDERING INFORMATION

Device	Package	Shipping†
NSR10F30QNXT5G	DSN2 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NSR10F30QNXT5G

## THERMAL CHARACTERISTICS

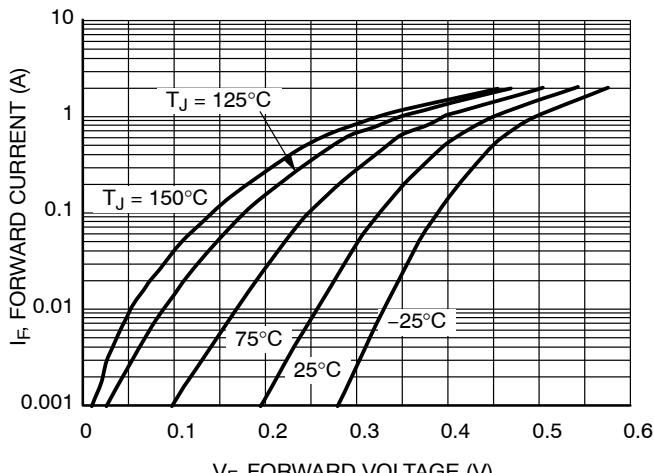
Characteristic	Symbol	Min	Typ	Max	Unit
Thermal Resistance Junction-to-Ambient (Note 1) Total Power Dissipation @ $T_A = 25^\circ\text{C}$	$R_{\theta\text{JA}}$ $P_D$			228 548	°C/W mW
Thermal Resistance Junction-to-Ambient (Note 2) Total Power Dissipation @ $T_A = 25^\circ\text{C}$	$R_{\theta\text{JA}}$ $P_D$			85 1.47	°C/W W
Storage Temperature Range	$T_{\text{stg}}$			-40 to +125	°C
Junction Temperature	$T_J$			+150	°C

1. Mounted onto a 4 in square FR-4 board 50 mm sq. 1 oz. Cu 0.06" thick single sided. Operating to steady state.
2. Mounted onto a 4 in square FR-4 board 1 in sq. 1 oz. Cu 0.06" thick single sided. Operating to steady state.

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

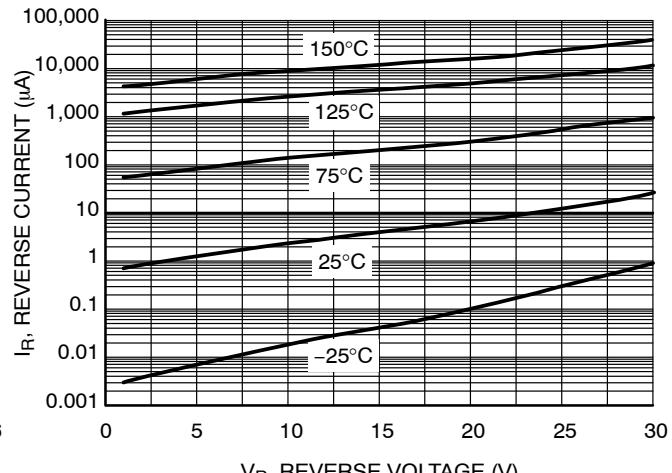
Characteristic	Symbol	Min	Typ	Max	Unit
Reverse Leakage ( $V_R = 10\text{ V}$ ) ( $V_R = 30\text{ V}$ )	$I_R$			20 100	µA
Forward Voltage ( $I_F = 0.5\text{ A}$ ) ( $I_F = 1.0\text{ A}$ )	$V_F$		0.400 0.450	0.420 0.470	V
Reverse Recovery (Special) Switch from Forward Current to Reverse Voltage Time taken from 1 ns Transition Time to Fully Stabilized ( $I_F = 1.5\text{ A}$ to $V_R = 28\text{ V}$ , $25^\circ\text{C}$ ) ( $I_F = 1.5\text{ A}$ to $V_R = 28\text{ V}$ , $85^\circ\text{C}$ )	$T_{RR}$		21.98 21.38		ns

## TYPICAL CHARACTERISTICS



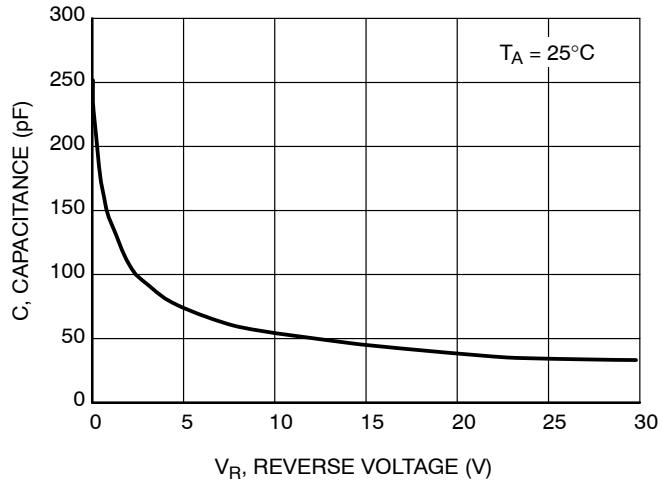
V<sub>F</sub>, FORWARD VOLTAGE (V)

**Figure 1. Forward Voltage**



V<sub>R</sub>, REVERSE VOLTAGE (V)

**Figure 2. Typical Reverse Current**



V<sub>R</sub>, REVERSE VOLTAGE (V)

**Figure 3. Typical Capacitance**



**Figure 4. Typical Reverse Recovery**

I<sub>F</sub> = 1.5 A to V<sub>R</sub> = 28 V

## APPLICATION SECTION

## Introduction

As wireless devices become smaller and thinner more compact, energy efficient, solutions are necessary. To reduce the solution size many people will integrate various discrete devices into the IC. While this may physically reduce the part count this has some adverse side effects, such as performance degradation. The best way to improve the solution is to use optimized discrete devices that have been shrunk and electrically optimized. In this paper we will discuss the intricacies of choosing an optimized Schottky diode for wireless devices.

First a discussion of high frequency boost converters as an application is explored. Then various trends in space saving and energy saving design will be discussed. Finally a stress test and a bench tests are shown.

## Background – Application

Most mobile phones use white LEDs to backlight the LCD display. These white LEDs typically have a forward voltage near 3.6 V. Since the typical power source in a mobile phone is a single-cell Li-Ion battery that has an input voltage range of 2.7 V to 4.2 V. Since more than one LED is required to backlight a LCD panel either a single string (~up to 10 LEDs in series) or multiple strings of LEDs (~ up to 10 LEDs in series) in parallel are used.

An example of a single string inductive boost circuit is shown in Figure 5. Typically, a very small voltage is measured over a precision resistor in series with the LEDs to feedback the output operation condition to the controller. Many of today's controllers integrate the transistors and the diode to save space.

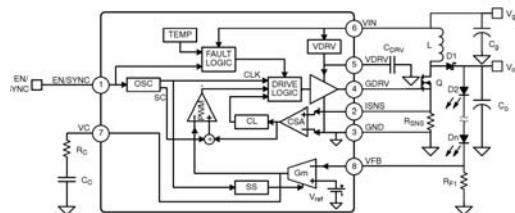


Figure 5. Simplified Typical Single Channel Converter

## Space Saving Ideas

The real issue with integrating all of the devices into the controller is that these power devices have an increased junction temperature compared to the controller. This increased junction temperature can lead to reliability issues due to the limited thermal conductivity of I.C. packages.

Another method for shrinking the size of an inductive boost application is to increase the switching frequency. When the switching frequency is increased a lower value inductors can be used to keep a constant inductor current

ripple. Lower value capacitors can be used because they become re-charged more frequently.

Unfortunately the transistor and the diode still need to carry the same average and peak currents. The LEDs for a backlight are generally set between 20 – 150 mA. This means that the transistor and diode need to conduct up to and above 1 A of current. If every element shrinks with exception to the diode and FET then all of this effort is for nothing. ON Semiconductor's High Frequency optimized schottky diodes solve this problem.

## Using ON Semiconductor's Optimized Schottky Diodes

To continue to reduce space requirements for a non-integrated, inductive boost circuit, a diode and a transistor with low power dissipation during operation in a package with high thermal conductivity is necessary. With the compact nature of wireless applications the space is very constrained and there is no place for a large heat sink (so a thermally efficient package is required).

Typically for a 1 A diode with a  $R_{\theta JA} = 86^{\circ}\text{C}/\text{W}$  a SMA package is used. The SMA package is 5.21 mm x 2.60 mm x 2.10 mm (L x W x H). ON Semiconductor's new optimized Schottky diode line these packages have a  $R_{\theta JA} = 85^{\circ}\text{C}/\text{W}$  and are only 1.4 mm x 0.6 mm x 0.27 mm (L x W x H). This means that the same power can be dissipated in only 8% of the total space. Not only is there is a thermal conductivity density advantage but there is also a performance improvement with these new optimized Schottky diodes.

## Thermal Stress Testing Bench Results

Before being tested a set of NSR10F30QNXT5G Boost Optimized Schottky diodes were characterized for forward voltage and reverse current over temperature. Next these diodes were placed in a "1 MHz" Boost converter, operating at near 750 kHz.

To augment the electrical stress seen on the ON Semiconductor Schottky Diodes an inductive boost regulator was set up with the following criteria: Input Voltage = 2.3 V, Output Voltage = 32 V, Output Load Current = 150 mA,  $L_1 = 10 \mu\text{H}$ . This will cause higher than normal currents to conduct through the diode.

To further augment the stress seen by the Schottky diode a thermal component to the test was added when the Schottky diodes were mounted to external PCBs with only a minimum footprint pad size. Twisted, shielded pair cable with an inductance of less than  $0.125 \mu\text{H}$  attached the diode PCBs to the "1 MHz" Boost board. This additional inductance is modeled in Figure 6 as  $L_{para1}$  and  $L_{para2}$  and seen as ringing. These cables allowed for the diode to run inside of an oven set to  $85^{\circ}\text{C}$  for 48 Hours.

After the 48-hour test was completed the diodes were taken back to the characterization lab for a post condition

## NSR10F30QNXT5G

analysis. This analysis showed that there was no shift in any of the parameters, forward voltage, reverse leakage current, and capacitance.

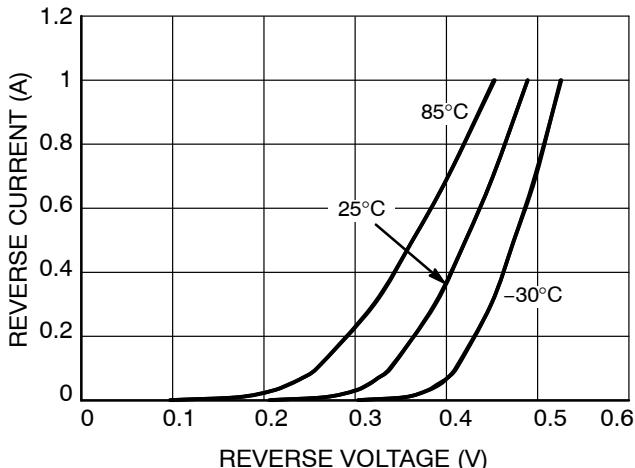
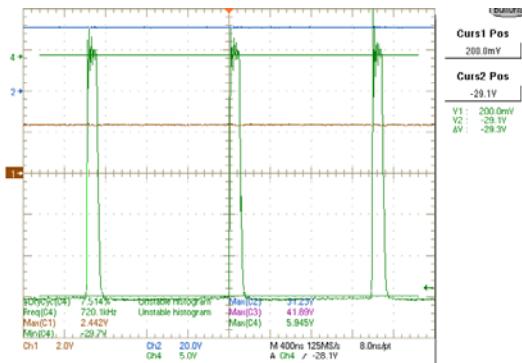


Figure 6. Reverse Leakage Characteristics

Finally these diodes were placed in the same circuit at 25°C for 1 week of continuous operation. The screen shots below in Figures 8 and 9 show the operation on the first day of continuous operation and 5 days respectively.



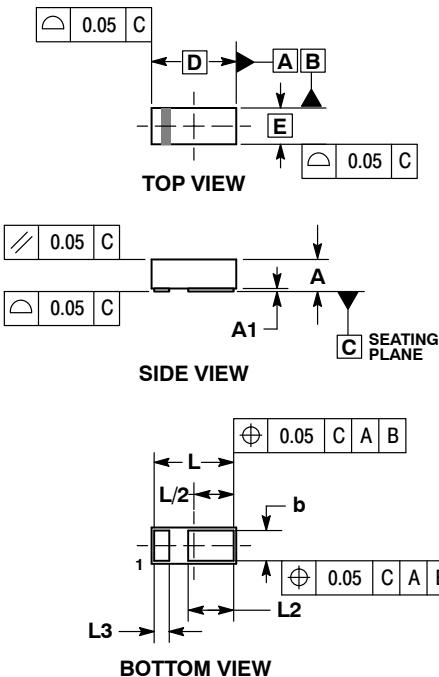
# NSR10F30QNXT5G

## PACKAGE DIMENSIONS

### DSN2, 1.4x0.6, 0.75P

CASE 152AD-01

ISSUE A

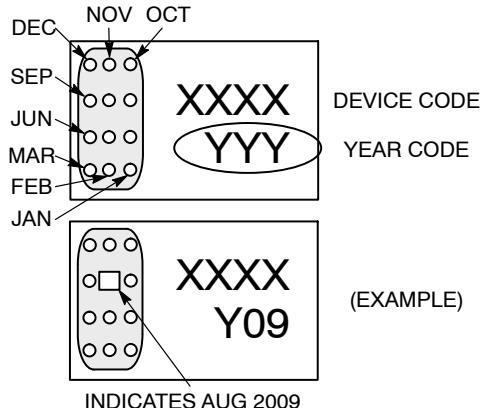


#### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.

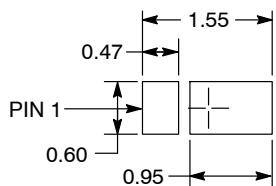
MILLIMETERS		
DIM	MIN	MAX
A	0.25	0.31
A1	---	0.05
b	0.45	0.55
D	1.40	BSC
E	0.60	BSC
L	1.20	1.30
L2	0.70	0.80
L3	0.20	0.30

### CATHODE BAND MONTH CODING



INDICATES AUG 2009

### MOUNTING FOOTPRINT\*



DIMENSIONS: MILLIMETERS

See Application Note AND8398/D for more mounting details

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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